

# PHOTOCOUPLER PS2711-1

# HIGH CTR 4-PIN SOP PHOTOCOUPLER

-NEPOC<sup>™</sup> Series-

#### **DESCRIPTION**

The PS2711-1 is an optically coupled isolator containing a GaAs light emitting diode and an NPN silicon phototransistor in a plastic SOP for high density applications.

The package is an SOP (Small Outline Package) type for high density mounting applications.

#### **FEATURES**

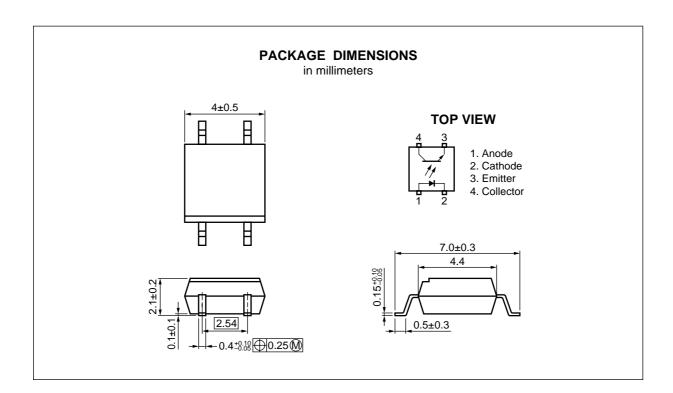
- High current transfer ratio (CTR = 200 % TYP. @ IF = 1mA)
- High isolation voltage (BV = 3 750 Vr.m.s.)
- Small and thin package (4-pin SOP)
- Ordering number of tape product: PS2711-1-F3, F4
- UL approved: File No. E72422 (S)

#### **APPLICATIONS**

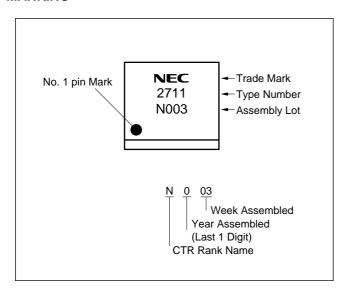
- · Programmable logic controllers
- Small power supply
- Hybrid IC
- Modem/FAX

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Not all devices/types available in every country. Please check with local NEC representative for availability and additional information.



### **MARKING**





### ORDERING INFORMATION

Part Number	Package	Packing Style	Safety Standards Approval	Application Part Number*1	
PS2711-1	4-pin SOP	50 pcs (Tape 50 pcs cut)	UL approved	PS2711-1	
PS2711-1-F3		Embossed Tape 3 500 pcs/reel			
PS2711-1-F4					

<sup>\*1</sup> For the application of the Safety Standard, following part number should be used.

### ABSOLUTE MAXIMUM RATINGS (TA = 25 °C, unless otherwise specified)

Parameter		Symbol	Ratings	Unit
Diode	Forward Current (DC)	lF	50	mA
	Reverse Voltage	VR	6	V
	Power Dissipation Derating	∆P₀/°C	0.8	mW/°C
	Power Dissipation	PD	80	mW
	Peak Forward Current <sup>*1</sup>	<b>I</b> FP	0.5	Α
Transistor	Collector to Emitter Voltage	Vceo	40	V
	Emitter to Collector Voltage	Veco	5	V
	Collector Current	lc	40	mA
	Power Dissipation Derating	∆Pc/°C	1.5	mW/°C
	Power Dissipation	Pc	150	mW
Isolation Voltage <sup>2</sup>		BV	3 750	Vr.m.s.
Operating Ambient Temperature		TA	-55 to +100	°C
Storage Temperature		T <sub>stg</sub>	-55 to +150	°C

<sup>\*1</sup> PW = 100  $\mu$ s, Duty Cycle = 1 %

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<sup>\*2</sup> AC voltage for 1 minute at  $T_A = 25$  °C, RH = 60 % between input and output



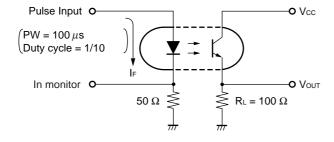
### ELECTRICAL CHARACTERISTICS (TA = 25 °C)

Parameter		Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Diode	Forward Voltage	VF	IF = 5 mA		1.15	1.4	V
	Reverse Current	lR	V <sub>R</sub> = 5 V			5	μΑ
	Terminal Capacitance	Ct	V = 0 V, f = 1 MHz		30		pF
Transistor	Collector to Emitter Dark Current	Iceo	IF = 0 mA, VcE = 40 V			100	nA
Coupled	Current Transfer Ratio	CTR	I <sub>F</sub> = 1 mA, V <sub>CE</sub> = 5 V	100	200	400	%
	Collector Saturation Voltage	VCE (sat)	I <sub>F</sub> = 1 mA, I <sub>C</sub> = 0.2 mA			0.3	V
	Isolation Resistance	R <sub>I-O</sub>	VI-O = 1 kVDC	10 <sup>11</sup>			Ω
	Isolation Capacitance	C <sub>I-O</sub>	V = 0 V, f = 1 MHz		0.4		pF
	Rise Time*2	tr	$Vcc = 5 \text{ V}, \text{ Ic} = 2 \text{ mA}, \text{ RL} = 100 \Omega$		4		μs
	Fall Time*2	<b>t</b> f			5		

### \*1 CTR rank

N: 100 to 400 (%) K: 200 to 400 (%) L: 150 to 300 (%) M: 100 to 200 (%)

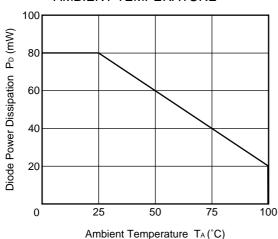
\*2 Test circuit for switching time



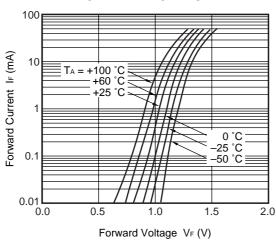
### NEC

#### TYPICAL CHARACTERISTICS (TA = 25 °C, unless otherwise specified)

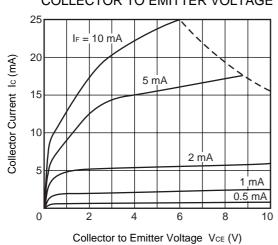




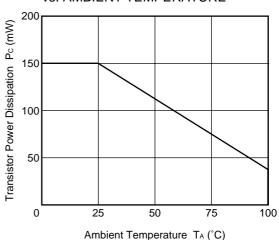
# FORWARD CURRENT vs. FORWARD VOLTAGE



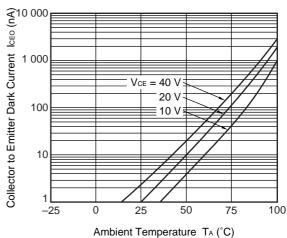
# COLLECTOR CURRENT vs. COLLECTOR TO EMITTER VOLTAGE



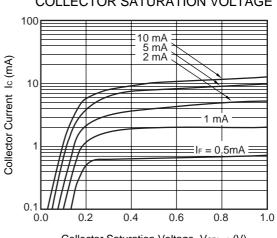
# TRANSISTOR POWER DISSIPATION vs. AMBIENT TEMPERATURE



# COLLECTOR TO EMITTER DARK CURRENT vs. AMBIENT TEMPERATURE



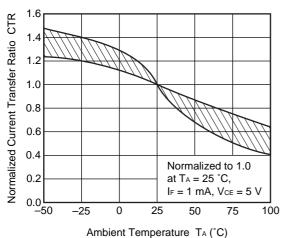
# COLLECTOR CURRENT vs. COLLECTOR SATURATION VOLTAGE



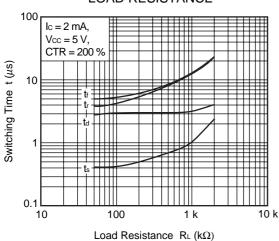
Collector Saturation Voltage  $V_{CE(sat)}(V)$ 



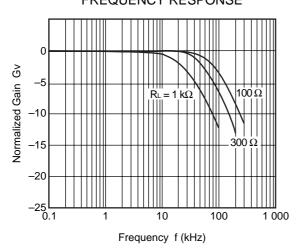
### NORMALIZED CURRENT TRANSFER RATIO vs. AMBIENT TEMPERATURE



### SWITCHING TIME vs. LOAD RESISTANCE

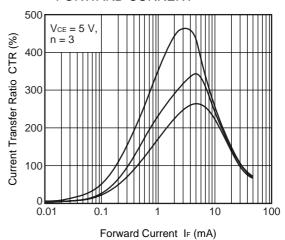


### FREQUENCY RESPONSE



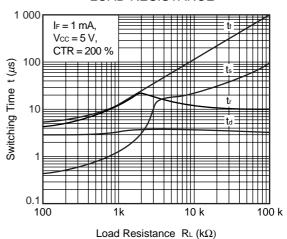
Remark The graphs indicate nominal characteristics.

# CURRENT TRANSFER RATIO vs. FORWARD CURRENT

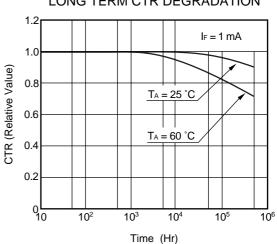


SWITCHING TIME VO

# SWITCHING TIME vs. LOAD RESISTANCE

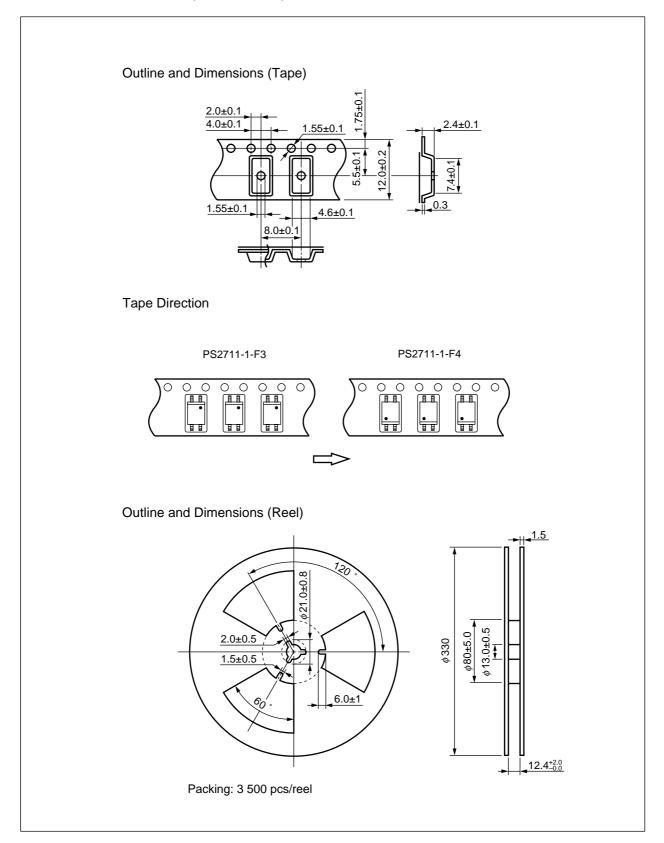


LONG TERM CTR DEGRADATION





### **TAPING SPECIFICATIONS (in millimeters)**



#### NOTES ON HANDLING

#### 1. Recommended soldering conditions

### (1) Infrared reflow soldering

Peak reflow temperature
 235 °C or below (package surface temperature)

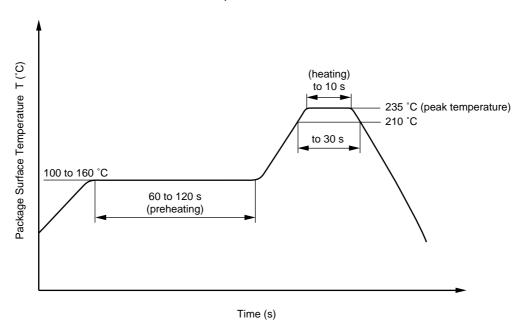
• Time of temperature higher than 210 °C 30 seconds or less

Number of reflows
 Three

• Flux Rosin flux containing small amount of chlorine (The flux with a

maximum chlorine content of 0.2 Wt % is recommended.)

### Recommended Temperature Profile of Infrared Reflow



#### (2) Dip soldering

• Temperature 260 °C or below (molten solder temperature)

• Time 10 seconds or less

• Number of times One (Allowed to be dipped in solder including plastic mold portion.)

• Flux Rosin flux containing small amount of chlorine (The flux with a maximum chlorine content of

0.2 Wt % is recommended.)

#### (3) Cautions

Fluxes

Avoid removing the residual flux with freon-based and chlorine-based cleaning solvent.

#### 2. Cautions regarding noise

Be aware that when voltage is applied suddenly between the photocoupler's input and output or between corrector-emitters at startup, the output side may enter the on state, even if the voltage is within the absolute maximum ratings.

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### **CAUTION**

Within this device there exists GaAs (Gallium Arsenide) material which is a harmful substance if ingested. Please do not under any circumstances break the hermetic seal.

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